

<b>Search Notes</b> 	<b>Application/Control No.</b>  09/803,011	<b>Applicant(s)/Patent under Reexamination</b>  SEKINE, YOSHINORI
	<b>Examiner</b>  EDMUND H. LEE	<b>Art Unit</b>  1732

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner